



SLOVENSKI STANDARD SIST EN IEC 61007:2020

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SIST EN 61007:2002

Transformatorji in induktorji za uporabo v elektronski in telekomunikacijski opremi - Metode merjenja in preskusni postopki

Transformers and inductors for use in electronic and telecommunication equipment -
Measuring methods and test procedures

Transformatoren und Drosseln für die Anwendung in elektronischen und
nachrichtentechnischen Einrichtungen - Meßmethoden und Prüfverfahren
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Transformateurs et inductances utilisés dans les équipements électroniques et de
télécommunications - Méthodes de mesure et procédures d'essais

Ta slovenski standard je istoveten z: EN IEC 61007:2020

ICS:

29.180 Transformatorji. Dušilke Transformers. Reactors

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EUROPEAN STANDARD

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September 2020

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Supersedes EN 61007:1997 and all of its amendments
and corrigenda (if any)

English Version

Transformers and inductors for use in electronic and
telecommunication equipment - Measuring methods and test
procedures
(IEC 61007:2020)

Transformateurs et inductances utilisés dans les
équipements électroniques et de télécommunications -
Méthodes de mesure et procédures d'essais
(IEC 61007:2020)

Transformatoren und Drosseln für die Anwendung in
elektronischen und nachrichtentechnischen Einrichtungen -
Messmethoden und Prüfverfahren
(IEC 61007:2020)

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European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Rue de la Science 23, B-1040 Brussels

EN IEC 61007:2020 (E)**European foreword**

The text of document 51/1319/CDV, future edition 3 of IEC 61007, prepared by IEC/TC 51 "Magnetic components, ferrite and magnetic powder materials" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN IEC 61007:2020.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2021-05-24
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2023-08-24

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In the official version, for Bibliography, the following notes have to be added for the standards indicated:

<https://standards.iteh.ai/catalog/standards/sist/268975b9-ab81-48c3-a398-35a00c39388a/sist-en-iec-61007-2020>

IEC 61000-2-2 NOTE Harmonized as EN 61000-2-2

IEC 61000-3-12 NOTE Harmonized as EN 61000-3-12

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 Where an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60050	series	International Electrotechnical Vocabulary	-	-
IEC 60068-1	2013	Environmental testing - Part 1: General and guidance	EN 60068-1	2014
IEC 60068-2-1	-	Environmental testing - Part 2-1: Tests - Test A: Cold	EN 60068-2-1	-
IEC 60068-2-2	-	Environmental testing - Part 2-2: Tests - Test B: Dry heat	EN 60068-2-2	-
IEC 60068-2-6	-	Environmental testing - Part 2-6: Tests - Test Fc: Vibration (sinusoidal)	EN 60068-2-6	-
IEC 60068-2-7	-	Basic environmental testing procedures - Part 2-7: Tests - Test Ga and guidance: Acceleration, steady state	EN 60068-2-7	-
IEC 60068-2-10	-	Environmental testing - Part 2-10: Tests - Test J and guidance: Mould growth	EN 60068-2-10	-
IEC 60068-2-13	-	Basic environmental testing procedures - Part 2-13: Tests - Test M: Low air pressure	EN 60068-2-13	-
IEC 60068-2-14	-	Environmental testing - Part 2-14: Tests - Test N: Change of temperature	EN 60068-2-14	-
IEC 60068-2-17	-	Basic environmental testing procedures - Part 2-17: Tests - Test Q: Sealing	EN 60068-2-17	-
IEC 60068-2-20	-	Environmental testing - Part 2-20: Tests - Test T: Test methods for solderability and resistance to soldering heat of devices with leads	EN 60068-2-20	-
IEC 60068-2-21	-	Environmental testing - Part 2-21: Tests - Test U: Robustness of terminations and integral mounting devices	EN 60068-2-21	-
IEC 60068-2-27	-	Environmental testing - Part 2-27: Tests - Test Ea and guidance: Shock	EN 60068-2-27	-

EN IEC 61007:2020 (E)

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60068-2-30	-	Environmental testing - Part 2-30: Tests - Test Db: Damp heat, cyclic (12 h + 12 h cycle)	EN 60068-2-30	-
IEC 60068-2-42	-	Environmental testing - Part 2-42: Tests - Test Kc: Sulphur dioxide test for contacts and connections	EN 60068-2-42	-
IEC 60068-2-45	-	Basic environmental testing procedures - Part 2-45: Tests - Test XA and guidance: Immersion in cleaning solvents	EN 60068-2-45	-
IEC 60068-2-52	-	Environmental testing – Part 2-52: Tests – Test Kb: Salt mist, cyclic (sodium chloride52 solution)	EN IEC 60068-2--	-
IEC 60068-2-78	-	Environmental testing - Part 2-78: Tests - Test Cab: Damp heat, steady state	EN 60068-2-78	-
IEC 60270	-	High-voltage test techniques - Partial discharge measurements	EN 60270	-
IEC 60695-11-2	-	Fire hazard testing -- Part 11-2: Test flames - 1 kW nominal premixed flame: Apparatus, confirmatory test arrangement and guidance	-	-
IEC 60695-11-5	-	Fire hazard testing - Part 11-5: Test flames Needle-flame test method - Apparatus, confirmatory test arrangement and guidance	EN 60695-11-5	-
IEC 61672-1	-	Electroacoustics - Sound level meters - Part 1: Specifications	EN 61672-1	-

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INTERNATIONAL STANDARD

NORME INTERNATIONALE

Transformers and inductors for use in electronic and telecommunication equipment – Measuring methods and test procedures

Transformateurs et inductances utilisés dans les équipements électroniques et de télécommunications – Méthodes de mesure et procédures d'essais

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

**TRANSFORMERS AND INDUCTORS FOR USE IN ELECTRONIC AND
TELECOMMUNICATION EQUIPMENT –
MEASURING METHODS AND TEST PROCEDURES**

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as “IEC Publication(s)”). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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International Standard IEC 61007 has been prepared by IEC technical committee 51: Magnetic components, ferrite and magnetic powder materials.

This third edition cancels and replaces the second edition published in 1994. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) scope: the application of the scope of IEC 61007 was extended;
- b) Clause 2: added new references and updated the references;
- c) Clause 3: new definitions were added in 3.3, and in 3.7 the voltage-time product was redefined;

d) test procedures were updated:

1) addition of test method:

AC resistance (in 4.4.1.2); short-circuit power test (in 4.4.3.4); efficiency (in 4.4.3.5); phase unbalance (in 4.4.5.7); amplitude unbalance (radio frequency) (in 4.4.5.8); transformation ratio by impedance (in 4.4.7.1); coefficient of coupling (in 4.4.7.2); cross-talk (in 4.4.10);

2) modification of test method:

Insulation resistance (an error range of the testing voltage, in 4.4.2.3);

3) deletion of test method:

Effective resistance;

e) environmental test procedures: new references were added;

f) Annexes A to G were added.

The text of this International Standard is based on the following documents:

CDV	Report on voting
51/1319/CDV	51/1339/RVC

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

TRANSFORMERS AND INDUCTORS FOR USE IN ELECTRONIC AND TELECOMMUNICATION EQUIPMENT – MEASURING METHODS AND TEST PROCEDURES

1 Scope

This document describes a number of tests for use in determining the significant parameters and performance characteristics of transformers and inductors for use in electronics and telecommunication equipment. These test methods are designed primarily for transformers and inductors used in all types of electronics applications that can be involved in any specification for such components. Even though these tests can be useful to the other types of transformers used in power distribution applications in utilities, industry, and others, the tests discussed in this document can supplement or complement the tests but are not intended to replace the tests in standards for transformers. Some of the tests described are intended for qualifying a product for a specific application, while others are test practices used for manufacturing and customer acceptance testing. The test methods described here include those parameters most commonly used in the electronics transformer and inductor industry: electric strength, resistance, power loss, inductance, impedance, balance, transformation ratio and many others used less frequently.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050 (all parts), *International Electrotechnical Vocabulary (IEV)* (available at www.electropedia.org)

IEC 60068-1: 2013, *Environmental testing – Part 1: General and guidance*

IEC 60068-2-1, *Environmental testing – Part 2-1: Tests – Tests A: Cold*

IEC 60068-2-2, *Environmental testing – Part 2-2: Tests – Tests 8: Dry heat*

IEC 60068-2-6, *Environmental testing – Part 2-6: Tests – Test Fc: Vibration (sinusoidal)*

IEC 60068-2-7, *Basic environmental testing procedures – Part 2-7: Tests – Test Ga and guidance: Acceleration, steady state*

IEC 60068-2-10, *Environmental testing – Part 2-10: Tests – Test J and guidance: Mould growth*

IEC 60068-2-13, *Basic environmental testing procedures – Part 2-13: Tests – Test M: Low air pressure*

IEC 60068-2-14, *Environmental testing – Part 2-14: Tests – Test N: Change of temperature*

IEC 60068-2-17, *Basic environmental testing procedure – Part 2-17: Tests – Test Q: Sealing*

IEC 60068-2-20, *Environmental testing – Part 2-20: Tests – Test T: Test methods for solderability and resistance to soldering heat of devices with leads*

IEC 60068-2-21, *Environmental testing – Part 2-21: Tests – Test U: Robustness of terminations and integral mounting devices*

IEC 60068-2-27, *Environmental testing – Part 2-27: Tests – Test Ea and guidance: Shock*

IEC 60068-2-30, *Environmental testing – Part 2-30: Tests – Test Db: Damp heat, cyclic (12 h + 12 h cycle)*

IEC 60068-2-42, *Environmental testing – Part 2-42: Tests – Test Kc: Sulphur dioxide test for contacts and connections*

IEC 60068-2-45, *Basic environmental testing procedures – Part 2-45: Tests – Test XA and guidance: Immersion in cleaning solvents*

IEC 60068-2-52, *Environmental testing – Part 2-52: Tests – Test Kb: Salt mist, cyclic (sodium chloride solution)*

IEC 60068-2-78, *Environmental testing – Part 2-78: Tests – Test Cab: Damp heat, steady state*

IEC 60270, *High-voltage test techniques – Partial discharge measurements*

IEC 60695-11-2, *Fire hazard testing – Part 11-2: Test flames – 1 kW pre-mixed flame – Apparatus, confirmatory test arrangement and guidance*

IEC 60695-11-5, *Fire hazard testing – Part 11-5: Test flames – Needle-flame test method – Apparatus, confirmatory test arrangement and guidance*

IEC 61672-1, *Electroacoustics – Sound level meters – Part 1: Specifications*

3 Terms and definitions

For the purposes of this document, the terms and definitions given in IEC 60050 (all parts) and the following apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- IEC Electromedia: available at <http://www.electropedia.org/>
- ISO Online browsing platform: available at <http://www.iso.org/obp>

3.1

component

transformer or inductor

3.2

peak working voltage

maximum instantaneous voltage for which the winding insulation is rated under working circuit conditions